

TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

## TC74ACT299P, TC74ACT299F

### 8-Bit PIPO Shift Register with Asynchronous Clear

The TC74ACT299 is an advanced high speed CMOS 8-BIT PIPO SHIFT REGISTER fabricated with silicon gate and double-layer metal wiring C<sup>2</sup>MOS technology.

It achieves the high speed operation similar to equivalent Bipolar Schottky TTL while maintaining the CMOS low power dissipation.

This device may be used as a level converter for interfacing TTL or NMOS to High Speed CMOS. The inputs are compatible with TTL, NMOS and CMOS output voltage levels.

It has a four modes (HOLD, SHIFT LEFT, SHIFT RIGHT and LOAD DATA) controlled by the two selection inputs (S0, S1).

When one or both enable ( $\overline{G1}$ ,  $\overline{G2}$ ) are high, the eight I/O outputs are forced to the high-impedance state; however, sequential operation or clearing of the register is not affected.

All inputs are equipped with protection circuits against static discharge or transient excess voltage.

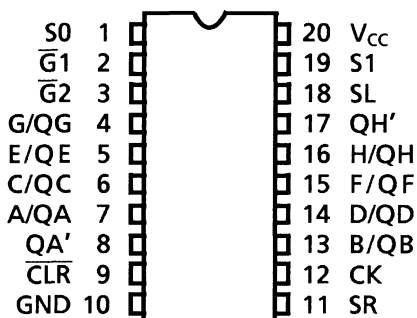
### Features (Note 1)(Note 2)

- High speed:  $f_{max} = 130$  MHz (typ.) at  $V_{CC} = 5$  V
- Low power dissipation:  $I_{CC} = 8$   $\mu$ A (max) at  $T_a = 25^\circ$ C
- Compatible with TTL outputs:  $V_{IL} = 0.8$  V (max)  
 $V_{IH} = 2.0$  V (min)
- Symmetrical output impedance:  $|I_{OH}| = I_{OL} = 24$  mA (min)  
Capability of driving 50  $\Omega$  transmission lines.
- Balanced propagation delays:  $t_{pLH} \approx t_{pHL}$
- Pin and function compatible with 74F299

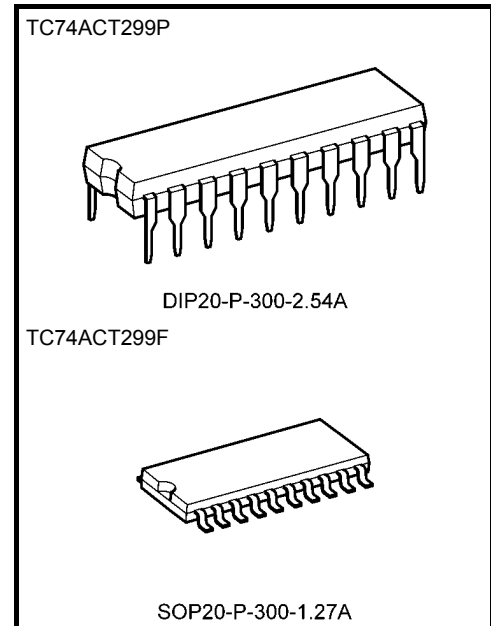
Note 1: Do not apply a signal to any bus terminal when it is in the output mode. Damage may result.

Note 2: All floating (high impedance) bus terminals must have their input levels fixed by means of pull up or pull down resistors.

### Pin Assignment



(TOP VIEW)

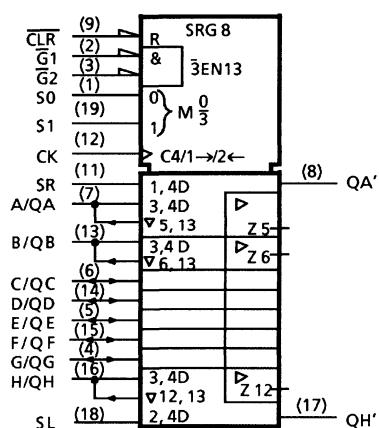


Weight

DIP20-P-300-2.54A : 1.30 g (typ.)

SOP20-P-300-1.27A : 0.22 g (typ.)

## IEC Logic Symbol



## Truth Table

Mode	Inputs								Inputs/ Outputs		Outputs	
	CLR	Function Select		Outputs Control		CK	Serial		A/QA	H/QH	QA'	QH'
		S1	S0	G1 (Note)	G2 (Note)		SL	SR				
Z	L	H	H	X	X	X	X	X	Z	Z	L	L
Clear	L	L	X	L	L	X	X	X	L	L	L	L
	L	X	L	L	L	X	X	X	L	L	L	L
Hold	H	L	L	L	L	X	X	X	QA0	QH0	QA0	QH0
Shift	H	L	H	L	L	↑	X	H	H	QGn	H	QGn
Right	H	L	H	L	L	↑	X	L	L	QGn	L	QGn
Shift	H	H	L	L	L	↑	H	X	QBn	H	QBn	H
Left	H	H	L	L	L	↑	L	X	QBn	L	QBn	L
Load	H	H	H	X	X	↑	X	X	a	h	a	h

Note: When one or both output controls are high, the eight input/output terminals are in the high-impedance state; however sequential or clearing of the register is not affected.

Z: High impedance

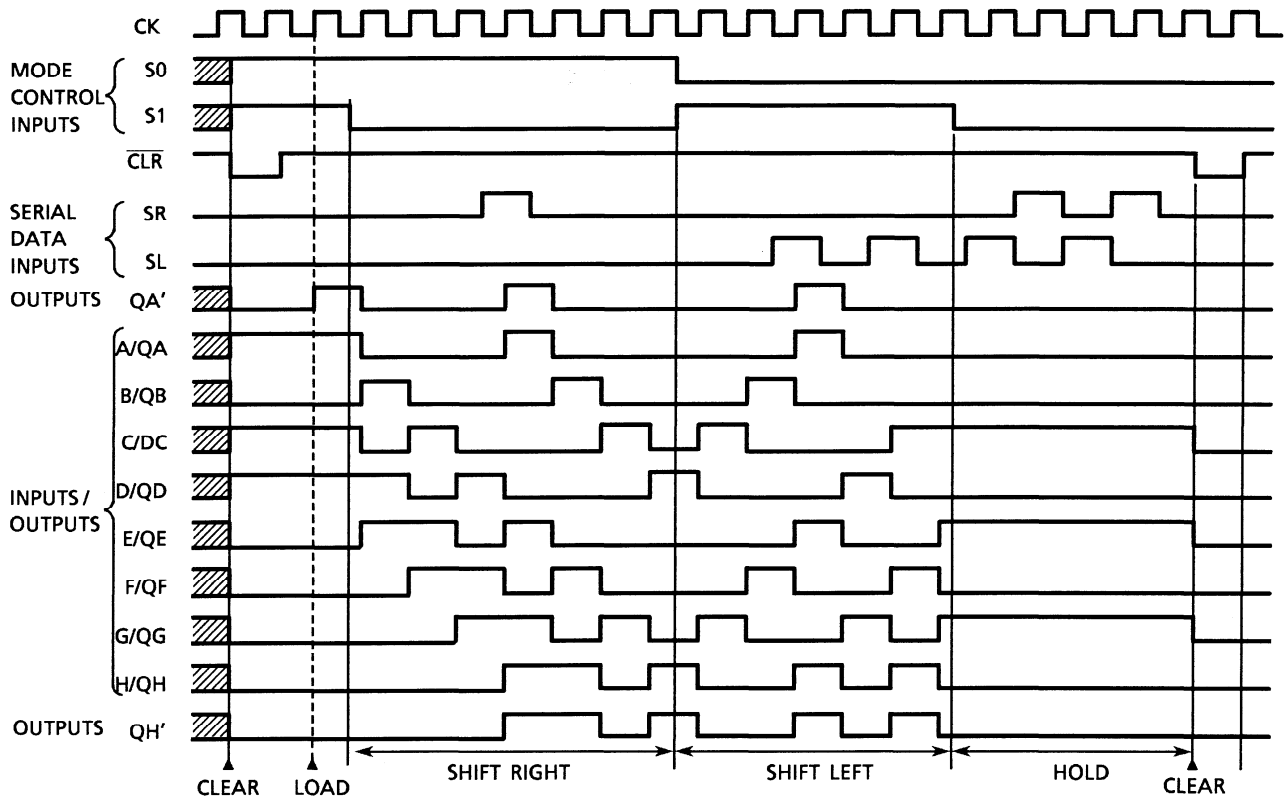
Qn0: The level of Qn before the indicated steady-state input conditions were established.

Qnn: The level of Qn before the most recent active transition indicated by ↓ or ↑.

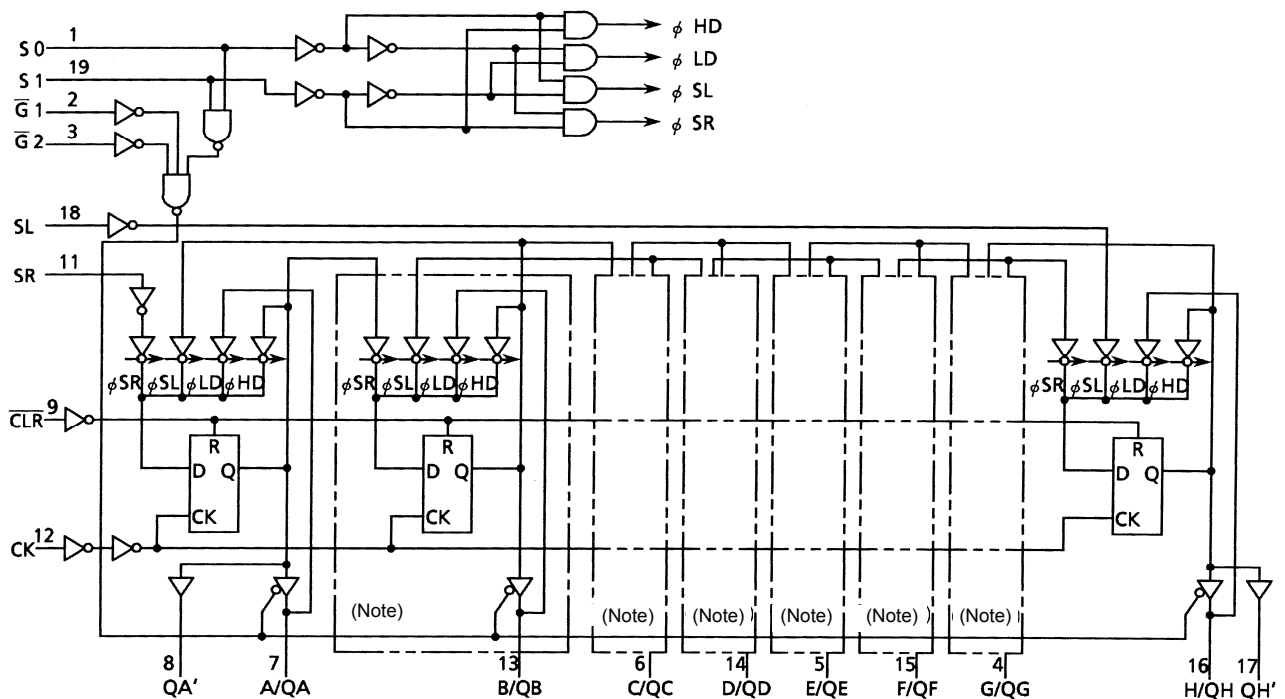
a, h: The level of the steady-state inputs A, H, respectively.

X: Don't care

## Timing Chart



## System Diagram



Note: Equivalent circuits

## Absolute Maximum Ratings (Note 1)

Characteristics	Symbol	Rating	Unit
Supply voltage range	$V_{CC}$	-0.5 to 7.0	V
DC input voltage	$V_{IN}$	-0.5 to $V_{CC} + 0.5$	V
DC output voltage	$V_{OUT}$	-0.5 to $V_{CC} + 0.5$	V
Input diode current	$I_{IK}$	$\pm 20$	mA
Output diode current	$I_{OK}$	$\pm 50$	mA
DC output current	$I_{OUT}$	$\pm 50$	mA
DC $V_{CC}$ /ground current	$I_{CC}$	$\pm 250$	mA
Power dissipation	$P_D$	500 (DIP) (Note 2)/180 (SOP)	mW
Storage temperature	$T_{stg}$	-65 to 150	°C

Note 1: Exceeding any of the absolute maximum ratings, even briefly, lead to deterioration in IC performance or even destruction.

Using continuously under heavy loads (e.g. the application of high temperature/current/voltage and the significant change in temperature, etc.) may cause this product to decrease in the reliability significantly even if the operating conditions (i.e. operating temperature/current/voltage, etc.) are within the absolute maximum ratings and the operating ranges.

Please design the appropriate reliability upon reviewing the Toshiba Semiconductor Reliability Handbook ("Handling Precautions"/"Derating Concept and Methods") and individual reliability data (i.e. reliability test report and estimated failure rate, etc.).

Note 2: 500 mW in the range of  $T_a = -40$  to  $65^\circ\text{C}$ . From  $T_a = 65$  to  $85^\circ\text{C}$  a derating factor of  $-10\text{ mW}/^\circ\text{C}$  should be applied up to 300 mW.

## Operating Ranges (Note)

Characteristics	Symbol	Rating	Unit
Supply voltage	$V_{CC}$	4.5 to 5.5	V
Input voltage	$V_{IN}$	0 to $V_{CC}$	V
Output voltage	$V_{OUT}$	0 to $V_{CC}$	V
Operating temperature	$T_{opr}$	-40 to 85	°C
Input rise and fall time	$dt/dV$	0 to 10	ns/V

Note: The operating ranges must be maintained to ensure the normal operation of the device. Unused inputs must be tied to either VCC or GND.

## Electrical Characteristics

## DC Characteristics

Characteristics	Symbol	Test Condition		V <sub>CC</sub> (V)	Ta = 25°C			Ta = -40 to 85°C		Unit
					Min	Typ.	Max	Min	Max	
High-level input voltage	V <sub>IH</sub>	—		4.5 to 5.5	2.0	—	—	2.0	—	V
Low-level input voltage	V <sub>IL</sub>	—		4.5 to 5.5	—	—	0.8	—	0.8	V
High-level output voltage	V <sub>OH</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OH</sub> = -50 µA	4.5	4.4	4.5	—	4.4	—	V
			I <sub>OH</sub> = -24 mA	4.5	3.94	—	—	3.80	—	
			I <sub>OH</sub> = -75 mA (Note)	5.5	—	—	—	3.85	—	
Low-level output voltage	V <sub>OL</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub>	I <sub>OL</sub> = 50 µA	4.5	—	0.0	0.1	—	0.1	V
			I <sub>OL</sub> = 24 mA	4.5	—	—	0.36	—	0.44	
			I <sub>OL</sub> = 75 mA (Note)	5.5	—	—	—	—	1.65	
3-state output off-state current	I <sub>OZ</sub>	V <sub>IN</sub> = V <sub>IH</sub> or V <sub>IL</sub> V <sub>OUT</sub> = V <sub>CC</sub> or GND		5.5	—	—	±0.5	—	±5.0	µA
Input leakage current	I <sub>IN</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	—	—	±0.1	—	±1.0	µA
Quiescent supply current	I <sub>CC</sub>	V <sub>IN</sub> = V <sub>CC</sub> or GND		5.5	—	—	8.0	—	80.0	µA
	I <sub>C</sub>	Per input: V <sub>IN</sub> = 3.4 V Other input: V <sub>CC</sub> or GND		5.5	—	—	1.35	—	1.5	mA

Note: This spec indicates the capability of driving 50 Ω transmission lines.

One output should be tested at a time for a 10 ms maximum duration.

Timing Requirements (input: t<sub>r</sub> = t<sub>f</sub> = 3 ns)

Characteristics	Symbol	Test Condition	Ta = 25°C		Ta = -40 to 85°C		Unit
			V <sub>CC</sub> (V)	Typ.	Limit	Limit	
Minimum pulse width (CK)	t <sub>W</sub> (L) t <sub>W</sub> (H)	—	5.0 ± 0.5	—	5.0	5.0	ns
Minimum pulse width ( $\overline{\text{CLR}}$ )	t <sub>W</sub> (L)	—	5.0 ± 0.5	—	5.0	5.0	ns
Minimum set-up time (SL, SR, A~H)	t <sub>s</sub>	—	5.0 ± 0.5	—	3.5	3.5	ns
Minimum set-up time (S0, S1)	t <sub>s</sub>	—	5.0 ± 0.5	—	6.0	6.5	ns
Minimum hold time (SL, SR, A~H)	t <sub>h</sub>	—	5.0 ± 0.5	—	2.0	2.0	ns
Minimum hold time (S0, S1)	t <sub>h</sub>	—	5.0 ± 0.5	—	0.0	0.0	ns
Minimum removal time ( $\overline{\text{CLR}}$ )	t <sub>rem</sub>	—	5.0 ± 0.5	—	2.0	2.0	ns

## AC Characteristics (C<sub>L</sub> = 50 pF, R<sub>L</sub> = 500 Ω, input: t<sub>r</sub> = t<sub>f</sub> = 3 ns)

Characteristics	Symbol	Test Condition		Ta = 25°C			Ta = -40 to 85°C		Unit
			V <sub>CC</sub> (V)	Min	Typ.	Max	Min	Max	
Propagation delay time (CK-QA', QH')	t <sub>pLH</sub> t <sub>pHL</sub>	—	5.0 ± 0.5	—	7.2	10.5	1.0	12.0	ns
Propagation delay time ( $\overline{\text{CLR}}$ -QA', QH')	t <sub>pHL</sub>	—	5.0 ± 0.5	—	6.0	10.0	1.0	11.5	ns
Propagation delay time (CK-QA~QH)	t <sub>pLH</sub> t <sub>pHL</sub>	—	5.0 ± 0.5	—	7.4	11.4	1.0	13.0	ns
Propagation delay time ( $\overline{\text{CLR}}$ -QA~QH)	t <sub>pHL</sub>	—	5.0 ± 0.5	—	6.3	10.5	1.0	12.0	ns
Output enable time	t <sub>pZL</sub> t <sub>pZH</sub>	—	5.0 ± 0.5	—	7.4	11.4	1.0	13.0	ns
Output disable time	t <sub>pLZ</sub> t <sub>pHZ</sub>	—	5.0 ± 0.5	—	7.2	9.6	1.0	11.0	ns
Maximum clock frequency	f <sub>max</sub>	—	5.0 ± 0.5	80	120	—	80	—	MHz
Input capacitance	C <sub>IN</sub>	—		—	5	10	—	10	pF
Bus input capacitance	C <sub>I/O</sub>	—		—	13	—	—	—	pF
Power dissipation capacitance	C <sub>PD</sub> (Note)	—		—	160	—	—	—	pF

Note: C<sub>PD</sub> is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption without load.

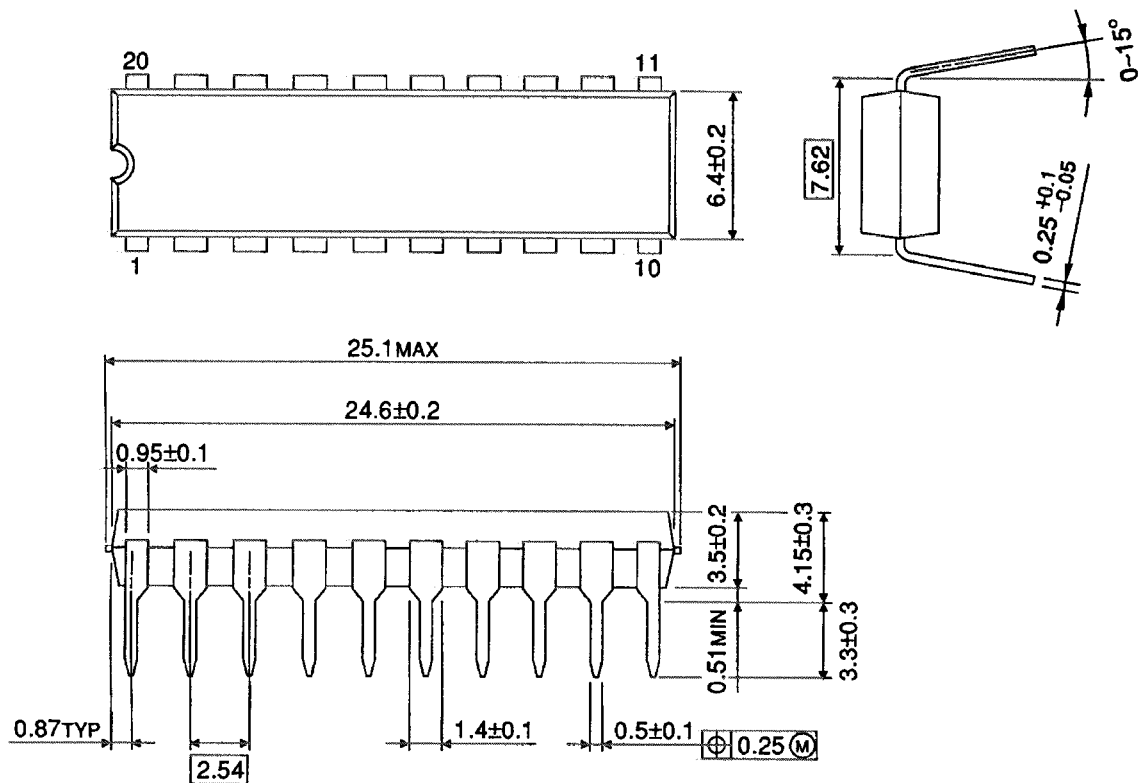
Average operating current can be obtained by the equation:

$$I_{CC}(\text{opr}) = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}$$

## Package Dimensions

DIP20-P-300-2.54A

Unit : mm

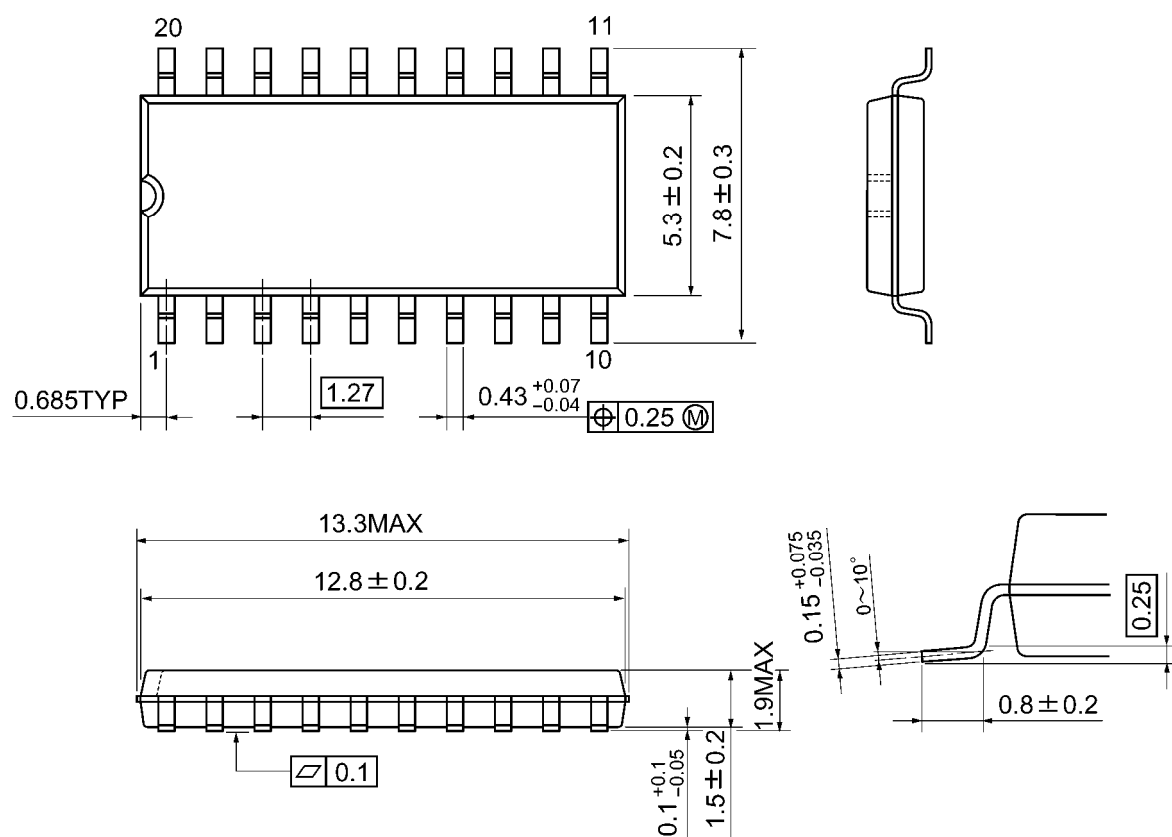


Weight: 1.30 g (typ.)

## Package Dimensions

SOP20-P-300-1.27A

Unit: mm



Weight: 0.22 g (typ.)



**RESTRICTIONS ON PRODUCT USE**

- Toshiba Corporation, and its subsidiaries and affiliates (collectively "TOSHIBA"), reserve the right to make changes to the information in this document, and related hardware, software and systems (collectively "Product") without notice.
- This document and any information herein may not be reproduced without prior written permission from TOSHIBA. Even with TOSHIBA's written permission, reproduction is permissible only if reproduction is without alteration/omission.
- Though TOSHIBA works continually to improve Product's quality and reliability, Product can malfunction or fail. Customers are responsible for complying with safety standards and for providing adequate designs and safeguards for their hardware, software and systems which minimize risk and avoid situations in which a malfunction or failure of Product could cause loss of human life, bodily injury or damage to property, including data loss or corruption. Before creating and producing designs and using, customers must also refer to and comply with (a) the latest versions of all relevant TOSHIBA information, including without limitation, this document, the specifications, the data sheets and application notes for Product and the precautions and conditions set forth in the "TOSHIBA Semiconductor Reliability Handbook" and (b) the instructions for the application that Product will be used with or for. Customers are solely responsible for all aspects of their own product design or applications, including but not limited to (a) determining the appropriateness of the use of this Product in such design or applications; (b) evaluating and determining the applicability of any information contained in this document, or in charts, diagrams, programs, algorithms, sample application circuits, or any other referenced documents; and (c) validating all operating parameters for such designs and applications. **TOSHIBA ASSUMES NO LIABILITY FOR CUSTOMERS' PRODUCT DESIGN OR APPLICATIONS.**
- Product is intended for use in general electronics applications (e.g., computers, personal equipment, office equipment, measuring equipment, industrial robots and home electronics appliances) or for specific applications as expressly stated in this document. Product is neither intended nor warranted for use in equipment or systems that require extraordinarily high levels of quality and/or reliability and/or a malfunction or failure of which may cause loss of human life, bodily injury, serious property damage or serious public impact ("Unintended Use"). Unintended Use includes, without limitation, equipment used in nuclear facilities, equipment used in the aerospace industry, medical equipment, equipment used for automobiles, trains, ships and other transportation, traffic signaling equipment, equipment used to control combustions or explosions, safety devices, elevators and escalators, devices related to electric power, and equipment used in finance-related fields. Do not use Product for Unintended Use unless specifically permitted in this document.
- Do not disassemble, analyze, reverse-engineer, alter, modify, translate or copy Product, whether in whole or in part.
- Product shall not be used for or incorporated into any products or systems whose manufacture, use, or sale is prohibited under any applicable laws or regulations.
- The information contained herein is presented only as guidance for Product use. No responsibility is assumed by TOSHIBA for any infringement of patents or any other intellectual property rights of third parties that may result from the use of Product. No license to any intellectual property right is granted by this document, whether express or implied, by estoppel or otherwise.
- **ABSENT A WRITTEN SIGNED AGREEMENT, EXCEPT AS PROVIDED IN THE RELEVANT TERMS AND CONDITIONS OF SALE FOR PRODUCT, AND TO THE MAXIMUM EXTENT ALLOWABLE BY LAW, TOSHIBA (1) ASSUMES NO LIABILITY WHATSOEVER, INCLUDING WITHOUT LIMITATION, INDIRECT, CONSEQUENTIAL, SPECIAL, OR INCIDENTAL DAMAGES OR LOSS, INCLUDING WITHOUT LIMITATION, LOSS OF PROFITS, LOSS OF OPPORTUNITIES, BUSINESS INTERRUPTION AND LOSS OF DATA, AND (2) DISCLAIMS ANY AND ALL EXPRESS OR IMPLIED WARRANTIES AND CONDITIONS RELATED TO SALE, USE OF PRODUCT, OR INFORMATION, INCLUDING WARRANTIES OR CONDITIONS OF MERCHANTABILITY, FITNESS FOR A PARTICULAR PURPOSE, ACCURACY OF INFORMATION, OR NONINFRINGEMENT.**
- Do not use or otherwise make available Product or related software or technology for any military purposes, including without limitation, for the design, development, use, stockpiling or manufacturing of nuclear, chemical, or biological weapons or missile technology products (mass destruction weapons). Product and related software and technology may be controlled under the Japanese Foreign Exchange and Foreign Trade Law and the U.S. Export Administration Regulations. Export and re-export of Product or related software or technology are strictly prohibited except in compliance with all applicable export laws and regulations.
- Please contact your TOSHIBA sales representative for details as to environmental matters such as the RoHS compatibility of Product. Please use Product in compliance with all applicable laws and regulations that regulate the inclusion or use of controlled substances, including without limitation, the EU RoHS Directive. TOSHIBA assumes no liability for damages or losses occurring as a result of noncompliance with applicable laws and regulations.